Composite Devices Silicon N-Channel MOS/Epitaxial Schottky Barrier

# SSM6H19NU

### 1. Applications

DC-DC Converters

### 2. Features

(1) N-channel MOSFET and a schottky barrier diode in one package.

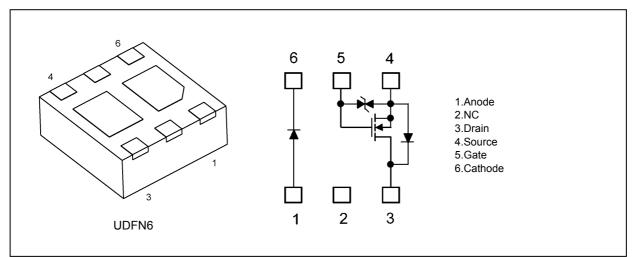
### 2.1. MOSFET Features

- (1) Low drain-source on-resistance :  $R_{DS(ON)} = 160 \text{ m}\Omega \text{ (typ.)} (@V_{GS} = 3.6 \text{ V})$
- (2) 1.8-V gate drive voltage.

### 2.2. Diode Features

(1) Low forward voltage:  $V_F = 0.51 \text{ V}$  (typ.) (@I<sub>F</sub> = 500 mA)

### 3. Packaging and Internal Circuit



### 4. Absolute Maximum Ratings (Note)

## 4.1. Absolute Maximum Ratings of the MOSFET (Unless otherwise specified, $T_a = 25$ °C)

Characteristics		Symbol	Rating	Unit
Drain-source voltage		V <sub>DSS</sub>	40	V
Gate-source voltage		V <sub>GSS</sub>	±12	
Drain current	(Note 1)	I <sub>D</sub>	2.0	А
Drain current (pulsed)	(Note 1)	I <sub>DP</sub>	4.0	
Channel temperature		T <sub>ch</sub>	150	°C

Note 1: Ensure that the channel temperature does not exceed 150  $^\circ\!\mathrm{C}.$ 

### 4.2. Absolute Maximum Ratings of the Diode (Unless otherwise specified, Ta = 25 °C)

Characteristics	Symbol	Rating	Unit
Reverse voltage	V <sub>R</sub>	40	V
Average rectified current	l <sub>o</sub>	500	mA
Non-repetitive peak forward surge current (t = 10 ms)	I <sub>FSM</sub>	5	А
Junction temperature	Tj	125	°C

## 4.3. Absolute Maximum Ratings of the Common Section (Unless otherwise specified, $T_a = 25$ °C)

Cł	naracteristics		Symbol	Rating	Unit
Power dissipation		(Note 1)	PD	1	W
Power dissipation	(t = 10 s)	(Note 1)		2	
Storage temperature			T <sub>stg</sub>	-55 to 150	°C

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

#### Note 1: P<sub>D</sub> for the entire IC Device mounted on a 25.4 mm × 25.4 mm × 1.6 mm FR-4 glass epoxy board (Cu pad: 645 mm<sup>2</sup>)

- Note: The MOSFETs in this device are sensitive to electrostatic discharge. When handling this device, the worktables, operators, soldering irons and other objects should be protected against anti-static discharge.
- Note: The channel-to-ambient thermal resistance, R<sub>th(ch-a)</sub>, and the drain power dissipation, P<sub>D</sub>, vary according to the board material, board area, board thickness and pad area. When using this device, be sure to take heat dissipation fully into account.

### 5. Electrical Characteristics

### 5.1. Static Characteristics of the MOSFET (Unless otherwise specified, T<sub>a</sub> = 25 °C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I <sub>GSS</sub>	V <sub>GS</sub> = ±10 V, V <sub>DS</sub> = 0 V	—	—	±10	μA
Drain cut-off current		I <sub>DSS</sub>	V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V	_		1	
Drain-source breakdown voltage		V <sub>(BR)DSS</sub>	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0 V	40	_	_	V
Drain-source breakdown voltage	(Note 1)	V <sub>(BR)DSX</sub>	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = -12 V	25	_	_	
Gate threshold voltage	(Note 2)	V <sub>th</sub>	V <sub>DS</sub> = 3 V, I <sub>D</sub> = 1 mA	0.5	_	1.2	
Drain-source on-resistance	(Note 3)	R <sub>DS(ON)</sub>	I <sub>D</sub> = 1.0 A, V <sub>GS</sub> = 8.0 V	_	145	185	mΩ
			I <sub>D</sub> = 1.0 A, V <sub>GS</sub> = 4.5 V	_	155	198	
			I <sub>D</sub> = 1.0 A, V <sub>GS</sub> = 4.2 V	_	156	201	
			I <sub>D</sub> = 1.0 A, V <sub>GS</sub> = 3.6 V	_	160	208	
			I <sub>D</sub> = 0.5 A, V <sub>GS</sub> = 2.5 V	_	180	238	
			I <sub>D</sub> = 0.2 A, V <sub>GS</sub> = 1.8 V	_	220	390	
Forward transfer admittance	(Note 3)	Y <sub>fs</sub>	V <sub>DS</sub> = 3 V, I <sub>D</sub> = 200 mA	_	2	_	S

Note 1: If a reverse bias is applied between gate and source, this device enters V<sub>(BR)DSX</sub> mode. Note that the drainsource breakdown voltage is lowered in this mode.

Note 2: Let  $V_{th}$  be the voltage applied between gate and source that causes the drain current (I<sub>D</sub>) to below (1 mA for this device). Then, for normal switching operation,  $V_{GS(ON)}$  must be higher than  $V_{th}$ , and  $V_{GS(OFF)}$  must be lower than  $V_{th}$ . This relationship can be expressed as:  $V_{GS(OFF)} < V_{th} < V_{GS(ON)}$ . Take this into consideration when using the device.

Note 3: Pulse measurement.

### 5.2. Dynamic Characteristics of the MOSFET (Unless otherwise specified, T<sub>a</sub> = 25 °C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Input capacitance	C <sub>iss</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	130	_	pF
Reverse transfer capacitance	C <sub>rss</sub>			7.5	_	
Output capacitance	C <sub>oss</sub>		_	26	—	
Switching time (turn-on time)	t <sub>on</sub>	$V_{DD} = 10 V, I_D = 0.5 A,$	_	13	—	ns
Switching time (turn-off time)	t <sub>off</sub>	$V_{GS}$ = 0 V to 2.5 V, R <sub>G</sub> = 4.7 $\Omega$ , See Figure 5.2.1, 5.2.2.	_	8	—	

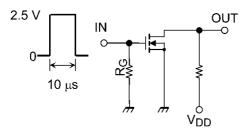


Fig. 5.2.1 Test Circuit of Switching Time

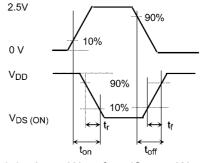


Fig. 5.2.2 Input Waveform/Output Waveform

# 5.3. Gate Charge Characteristics of the MOSFET (Unless otherwise specified, $T_a = 25$ °C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Total gate charge (gate-source plus gate-drain)	Qg	V <sub>DD</sub> = 10 V, I <sub>D</sub> = 1.8 A V <sub>GS</sub> = 4.2 V	—	1.1	2.2	nC
		V <sub>DD</sub> = 10 V, I <sub>D</sub> = 1.8 A V <sub>GS</sub> = 3.6 V	—	1.0	2.0	
		V <sub>DD</sub> = 10 V, I <sub>D</sub> = 1.8 A V <sub>GS</sub> = 2.5 V	—	0.75	1.5	

# 5.4. Source-Drain Characteristics of the MOSFET (Unless otherwise specified, $T_a = 25 \text{ °C}$ )

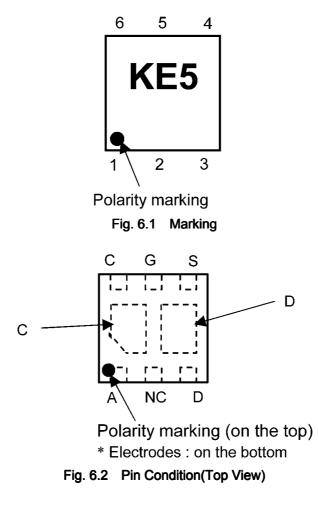
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Diode forward voltage (No	te 1) V <sub>DSF</sub>	I <sub>D</sub> = -2.0 A, V <sub>GS</sub> = 0 V	-	-0.85	-1.2	V

Note 1: Pulse measurement.

### 5.5. Characteristics of the Diode (Unless otherwise specified, $T_a = 25$ °C)

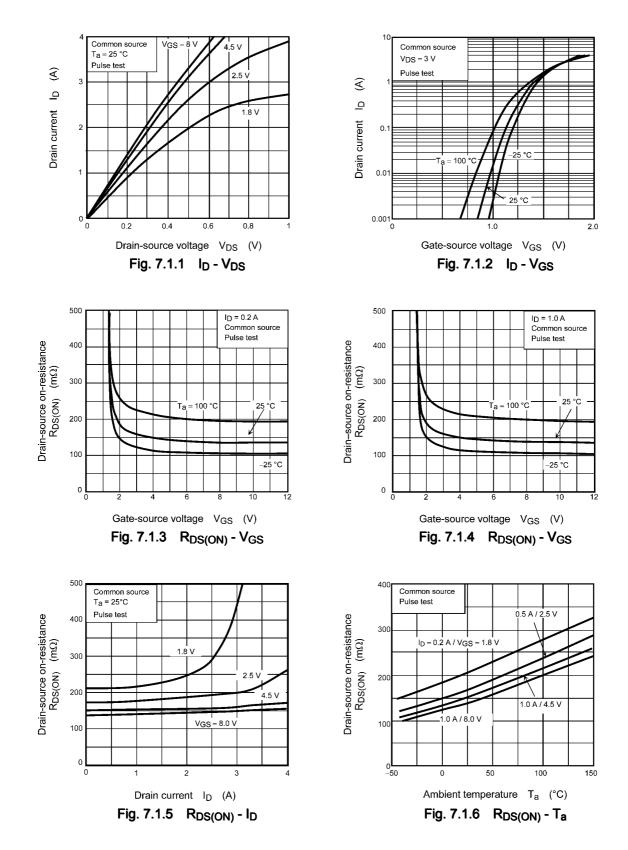
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Forward voltage	V <sub>F(1)</sub>	I <sub>F</sub> = 100 mA	_	0.31	0.35	V
	V <sub>F(2)</sub>	I <sub>F</sub> = 500 mA	_	0.51	0.57	
Reverse current	I <sub>R</sub>	V <sub>R</sub> = 40 V			50	μA
Total capacitance	Ct	V <sub>R</sub> = 0 V, f = 1 MHz		42	_	pF

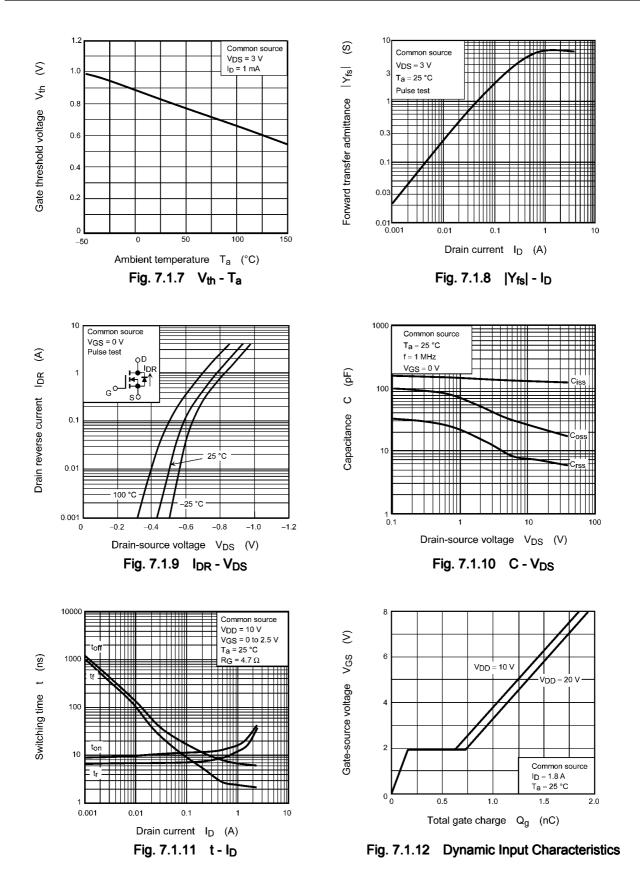
### 6. Marking



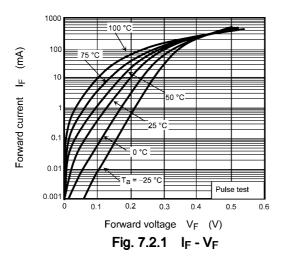
7. Characteristics Curves (Note)

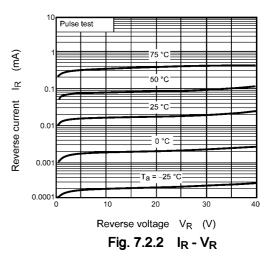
### 7.1. Characteristics Curves of the MOSFET

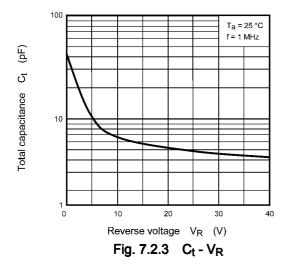




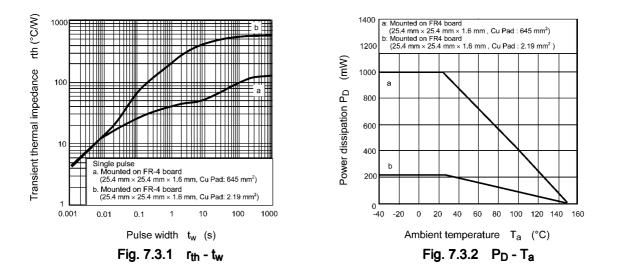
### 7.2. Characteristics Curves of the Diode







### 7.3. Characteristics Curves of the MOSFET $\cdot$ Diodes Common

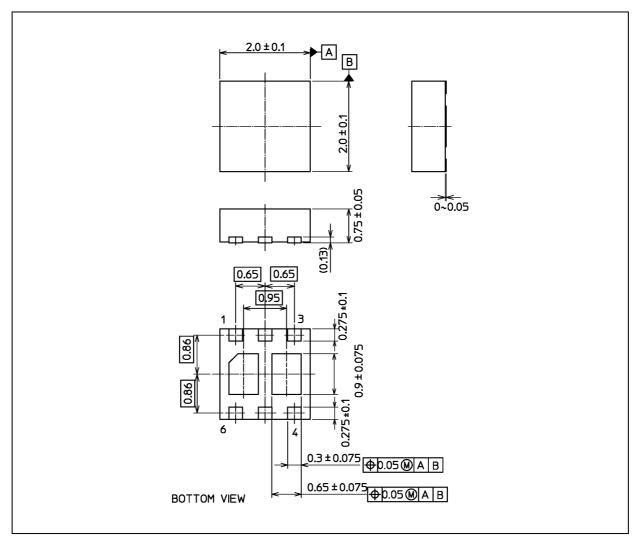


Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

### **Package Dimensions**

SSM6H19NU

Unit: mm



Weight: 8.5 mg (typ.)

Package Name(s)

Nickname: UDFN6

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